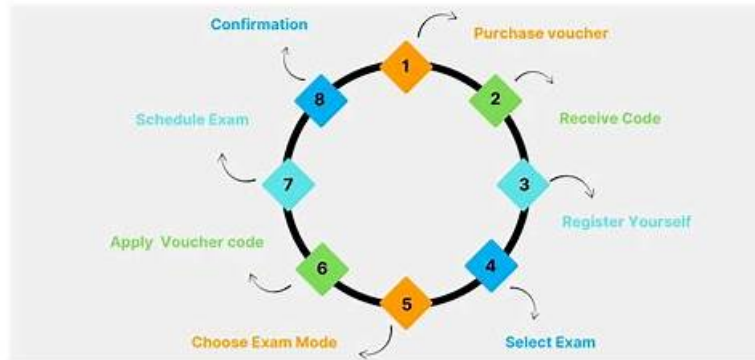


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ISTQB CT-AI Exam Syllabus Topics:

Topic	Details
Topic 1	<ul style="list-style-type: none">systems from those required for conventional systems.
Topic 2	<ul style="list-style-type: none">Machine Learning ML: This section includes the classification and regression as part of supervised learning, explaining the factors involved in the selection of ML algorithms, and demonstrating underfitting and overfitting.
Topic 3	<ul style="list-style-type: none">Quality Characteristics for AI-Based Systems: This section covers topics covered how to explain the importance of flexibility and adaptability as characteristics of AI-based systems and describes the vitality of managing evolution for AI-based systems. It also covers how to recall the characteristics that make it difficult to use AI-based systems in safety-related applications.
Topic 4	<ul style="list-style-type: none">Testing AI-Specific Quality Characteristics: In this section, the topics covered are about the challenges in testing created by the self-learning of AI-based systems.
Topic 5	<ul style="list-style-type: none">Neural Networks and Testing: This section of the exam covers defining the structure and function of a neural network including a DNN and the different coverage measures for neural networks.
Topic 6	<ul style="list-style-type: none">ML Functional Performance Metrics: In this section, the topics covered include how to calculate the ML functional performance metrics from a given set of confusion matrices.
Topic 7	<ul style="list-style-type: none">Test Environments for AI-Based Systems: This section is about factors that differentiate the test environments for AI-based
Topic 8	<ul style="list-style-type: none">Testing AI-Based Systems Overview: In this section, focus is given to how system specifications for AI-based systems can create challenges in testing and explain automation bias and how this affects testing.

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ISTQB Certified Tester AI Testing Exam Sample Questions (Q45-Q50):

NEW QUESTION # 45

A startup company has implemented a new facial recognition system for a banking application for mobile devices. The application is intended to learn at run-time on the device to determine if the user should be granted access. It also sends feedback over the Internet to the application developers. The application deployment resulted in continuous restarts of the mobile devices.

Which of the following is the most likely cause of the failure?

- A. The size of the application is consuming too much of the phone's storage capacity.
- B. Mobile operating systems cannot process machine learning algorithms.
- **C. The training, processing, and diagnostic generation are too computationally intensive for the mobile device hardware to handle.**
- D. The feedback requires a physical connection and cannot be sent over the Internet.

Answer: C

Explanation:

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Facial recognition applications involve complex computational tasks, including:

- * Feature Extraction- Identifying unique facial landmarks.
- * Model Training and Updates- Continuous learning and adaptation of user data.
- * Image Processing- Handling real-time image recognition under various lighting and angles.

In this scenario, the mobile device is experiencing continuous restarts, which suggests a resource overload caused by excessive processing demands.

- * Mobile devices have limited computational power.
- * Unlike servers, mobile devices lack powerful GPUs/TPUs required for deep learning models.
- * On-device learning is computationally expensive.
- * The model is likely performing real-time learning, which can overwhelm the CPU and RAM.
- * Continuous feedback transmission may cause overheating.
- * If the system is running multiple processes-training, inference, and network communication-it can overload system resources and cause crashes.
- * (A) The feedback requires a physical connection and cannot be sent over the Internet. # (Incorrect)
- * Feedback transmission over the internet is common for cloud-based AI services. This is not the cause of the issue.
- * (B) Mobile operating systems cannot process machine learning algorithms. # (Incorrect)
- * Many mobile applications use ML models efficiently. The problem here is the high computational intensity, not the OS's ability to run ML algorithms.
- * (C) The size of the application is consuming too much of the phone's storage capacity. # (Incorrect)
- * Storage issues typically result in installation failures or lag, not device restarts. The issue here is processing overload, not storage space.
- * AI-based applications require significant computational power. "The computational intensity of AI-based applications can pose a challenge when deployed on resource-limited devices."
- * Edge devices may struggle with processing complex ML workloads. "Deploying AI models on mobile or edge devices requires optimization, as these devices have limited processing capabilities compared to cloud environments." Why is Option D Correct? Why Other Options are Incorrect? References from ISTQB Certified Tester AI Testing Study Guide Thus, option D is the correct answer, as the computational demands of the facial recognition system are too high for the mobile hardware to handle, causing continuous restarts.

NEW QUESTION # 46

In the near future, technology will have evolved, and AI will be able to learn multiple tasks by itself without needing to be retrained, allowing it to operate even in new environments. The cognitive abilities of AI are similar to a child of 1-2 years.' In the above quote, which ONE of the following options is the correct name of this type of AI?

SELECT ONE OPTION

- A. Super AI
- B. Technological singularity
- **C. General AI**
- D. Narrow AI

Answer: C

Explanation:

* A. Technological singularity

Technological singularity refers to a hypothetical point in the future when AI surpasses human intelligence and can continuously improve itself without human intervention. This scenario involves capabilities far beyond those described in the question.

* B. Narrow AI

Narrow AI, also known as weak AI, is designed to perform a specific task or a narrow range of tasks. It does not have general cognitive abilities and cannot learn multiple tasks by itself without retraining.

* C. Super AI

Super AI refers to an AI that surpasses human intelligence and capabilities across all fields. This is an advanced concept and not aligned with the description of having cognitive abilities similar to a young child.

* D. General AI

General AI, or strong AI, has the ability to understand, learn, and apply knowledge across a wide range of tasks, similar to human cognitive abilities. It aligns with the description of AI that can learn multiple tasks and operate in new environments without needing retraining.

NEW QUESTION # 47

You have been developing test automation for an e-commerce system. One of the problems you are seeing is that object recognition in the GUI is having frequent failures. You have determined this is because the developers are changing the identifiers when they make code updates. How could AI help make the automation more reliable?

- A. It could generate a model that will anticipate developer changes and pre-alter the test automation code accordingly
- **B. It could identify the objects multiple ways and then determine the most commonly used and stable identification for each object**
- C. It could dynamically name the objects, altering the source code, so the object names will match the object names used in the automation
- D. It could modify the automation code to ignore unrecognizable objects to avoid failures

Answer: B

Explanation:

The syllabus discusses using AI-based tools to reduce GUI test brittleness:

"AI can be used to reduce the brittleness of this approach, by employing AI-based tools to identify the correct objects using various criteria (e.g., XPath, label, id, class, X/Y coordinates), and to choose the historically most stable identification criteria." (Reference: ISTQB CT-AI Syllabus v1.0, Section 11.6.1)

NEW QUESTION # 48

Which ONE of the following models BEST describes a way to model defect prediction by looking at the history of bugs in modules by using code quality metrics of modules of historical versions as input?

SELECT ONE OPTION

- A. Search of similar code based on natural language processing.
- **B. Using a classification model to predict the presence of a defect by using code quality metrics as the input data.**
- C. Identifying the relationship between developers and the modules developed by them.
- D. Clustering of similar code modules to predict based on similarity.

Answer: B

Explanation:

Defect prediction models aim to identify parts of the software that are likely to contain defects by analyzing historical data and code quality metrics. The primary goal is to use this predictive information to allocate testing and maintenance resources effectively. Let's break down why option D is the correct choice:

* Understanding Classification Models:

* Classification models are a type of supervised learning algorithm used to categorize or classify data into predefined classes or labels. In the context of defect prediction, the classification model would classify parts of the code as either "defective" or "non-defective" based on the input features.

* Input Data - Code Quality Metrics:

* The input data for these classification models typically includes various code quality metrics such as cyclomatic complexity, lines of code, number of methods, depth of inheritance, coupling between objects, etc. These metrics help the model learn patterns associated with defects.

* Historical Data:

* Historical versions of the code along with their defect records provide the labeled data needed for training the classification model. By analyzing this historical data, the model can learn which metrics are indicative of defects.

* Why Option D is Correct:

* Option D specifies using a classification model to predict the presence of defects by using code quality metrics as input data. This accurately describes the process of defect prediction using historical bug data and quality metrics.

* Eliminating Other Options:

* A. Identifying the relationship between developers and the modules developed by them:

This does not directly involve predicting defects based on code quality metrics and historical data.

* B. Search of similar code based on natural language processing: While useful for other purposes, this method does not describe defect prediction using classification models and code metrics.

* C. Clustering of similar code modules to predict based on similarity: Clustering is an unsupervised learning technique and does not directly align with the supervised learning approach typically used in defect prediction models.

References:

* ISTQB CT-AI Syllabus, Section 9.5, Metamorphic Testing (MT), describes various testing techniques including classification models for defect prediction.

* "Using AI for Defect Prediction" (ISTQB CT-AI Syllabus, Section 11.5.1).

NEW QUESTION # 49

Which ONE of the following characteristics is the least likely to cause safety related issues for an AI system?

SELECT ONE OPTION

- A. High complexity
- **B. Robustness**
- C. Non-determinism
- D. Self-learning

Answer: B

Explanation:

The question asks which characteristic is least likely to cause safety-related issues for an AI system. Let's evaluate each option:

Non-determinism (A): Non-deterministic systems can produce different outcomes even with the same inputs, which can lead to unpredictable behavior and potential safety issues.

Robustness (B): Robustness refers to the ability of the system to handle errors, anomalies, and unexpected inputs gracefully. A robust system is less likely to cause safety issues because it can maintain functionality under varied conditions.

High complexity (C): High complexity in AI systems can lead to difficulties in understanding, predicting, and managing the system's behavior, which can cause safety-related issues.

Self-learning (D): Self-learning systems adapt based on new data, which can lead to unexpected changes in behavior. If not properly monitored and controlled, this can result in safety issues.

Reference:

ISTQB CT-AI Syllabus Section 2.8 on Safety and AI discusses various factors affecting the safety of AI systems, emphasizing the importance of robustness in maintaining safe operation.

NEW QUESTION # 50

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